

Search Notes

Application/Control No.

10/820,257

Examiner

Dieu-Minh Le

Applicant(s)/Patent under
Reexamination

JAIN ET AL.

Art Unit

2114

SEARCHED

Class	Subclass	Date	Examiner
714	4	12/12/2006	DML
370	218		
	217		
709	238		
709	239	12/12/2006	DML

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search files USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM-TDB.	12/12/2006	DML
Inventor names search.	12/12/2006	DML